

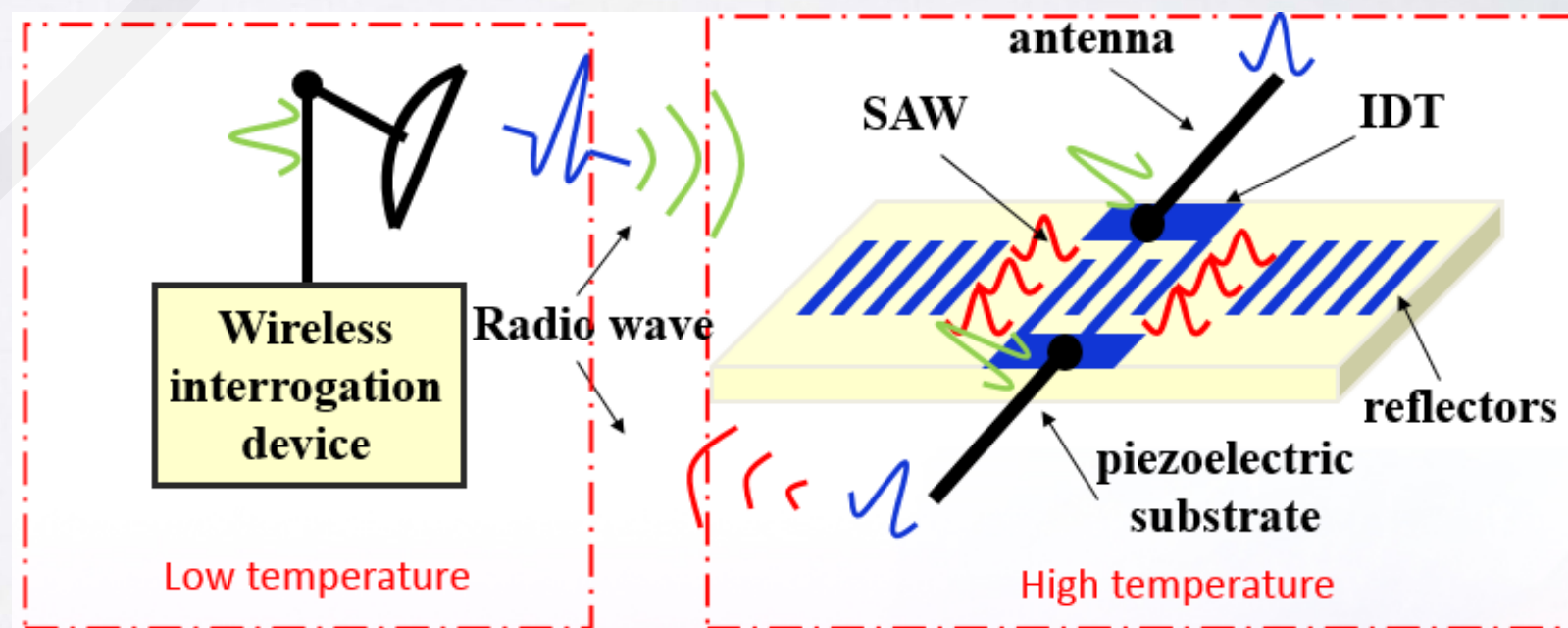
Cite this as: Wei-zhong Wang, Ji Liang, Yong Ruan, Wei Pang, Zheng You, 2017. Design and fabrication of an surface acoustic wave resonator based on AlN/4H-SiC material for harsh environments. *Journal of Zhejiang University-SCIENCE A (Applied Physics & Engineering)*, 18(1):67-74.

<http://dx.doi.org/10.1631/jzus.A1600028>

Design and fabrication of an surface acoustic wave resonator based on AlN/4H-SiC material for harsh environments

Key words:

SAW resonator, AlN/4H-SiC, harsh environment, MEMS technology, gas turbine



application requirement



300~600°C

terrestrial heat exploitation



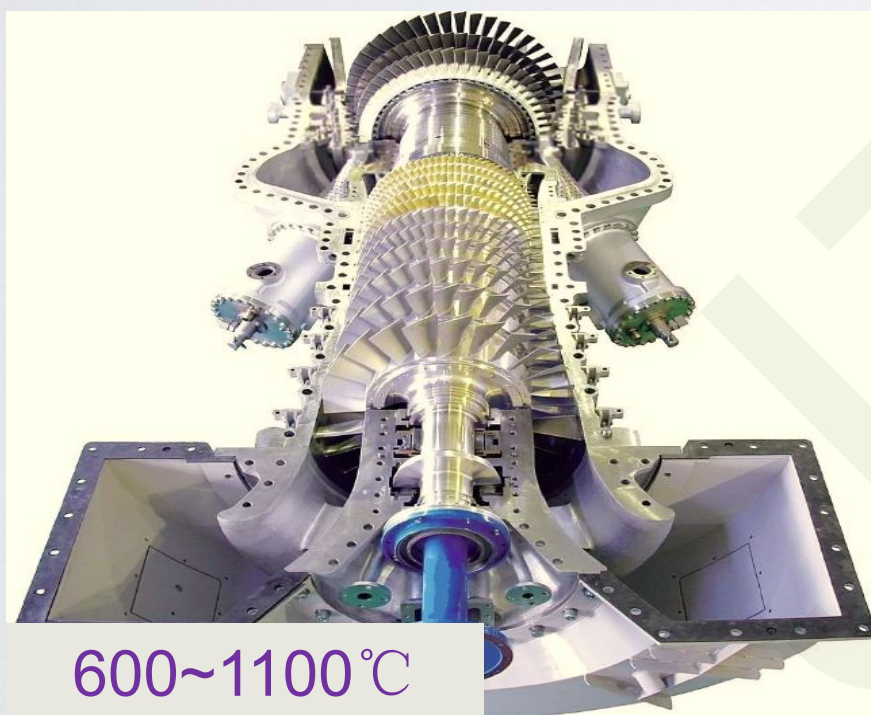
300~600°C

automotive engines



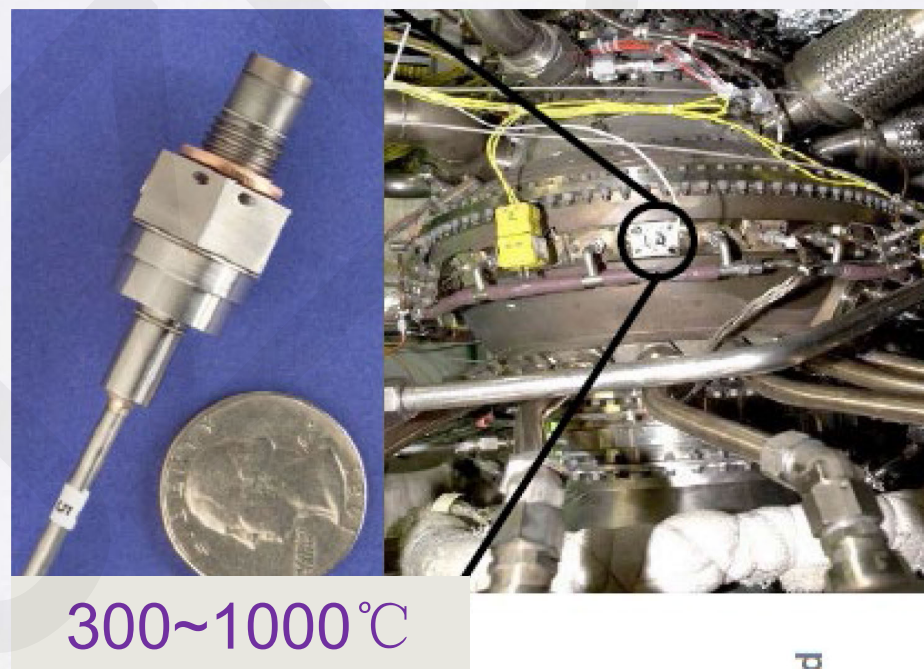
200~1000°C

hypersonic aircraft



600~1100°C

gas turbine



300~1000°C

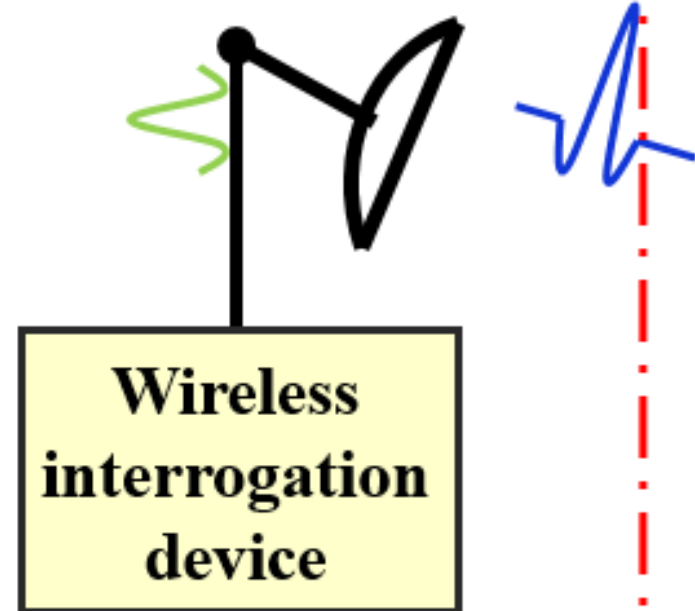
turbojet engine



800°C~2600°C

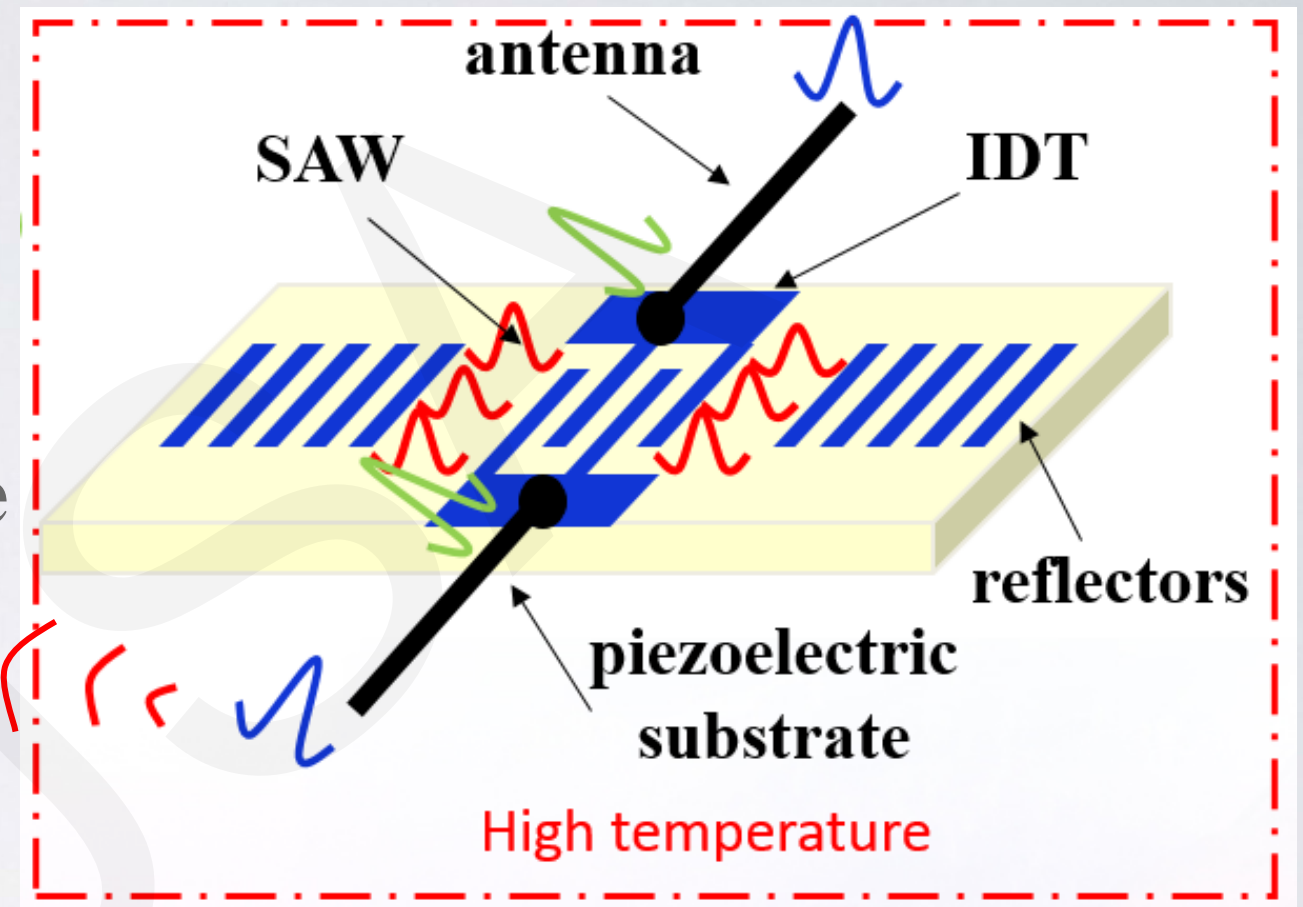
near space aerocraft

MEMS+SAW



Low temperature

Radio wave



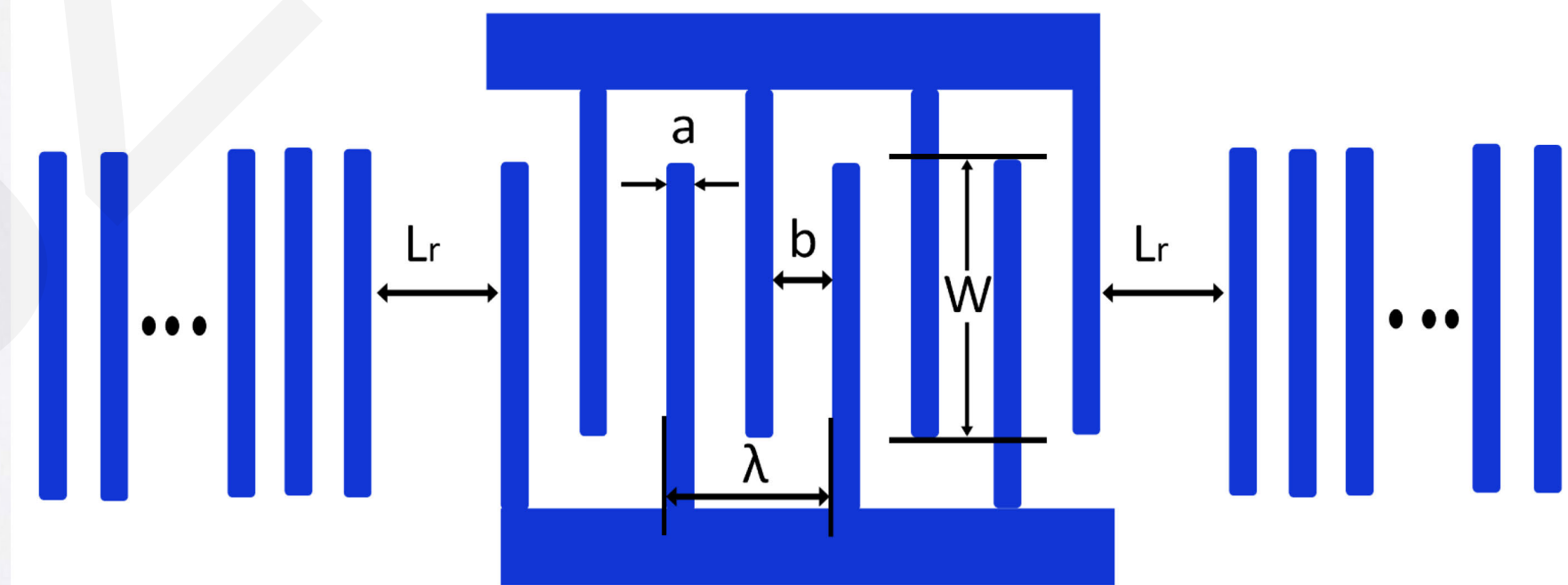
High temperature

High-temperature Wireless MEMS Temperature Sensing System

Parameter design

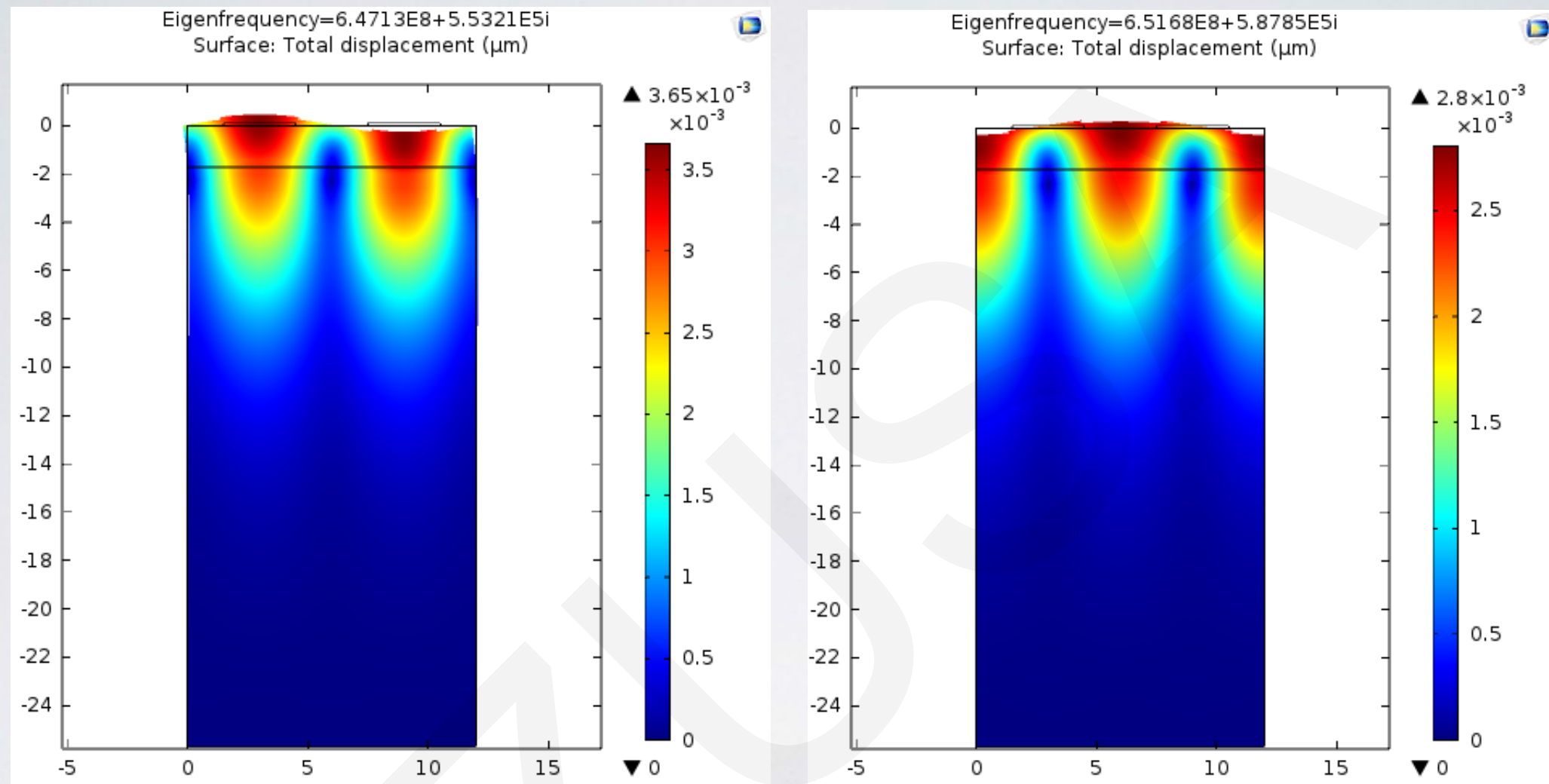
$$f = \frac{V_s}{\lambda_0} \quad a + b = N \frac{\lambda_0}{2}$$

$$L_r = \left(N - \frac{1}{2}\right) \frac{\lambda_0}{2}$$



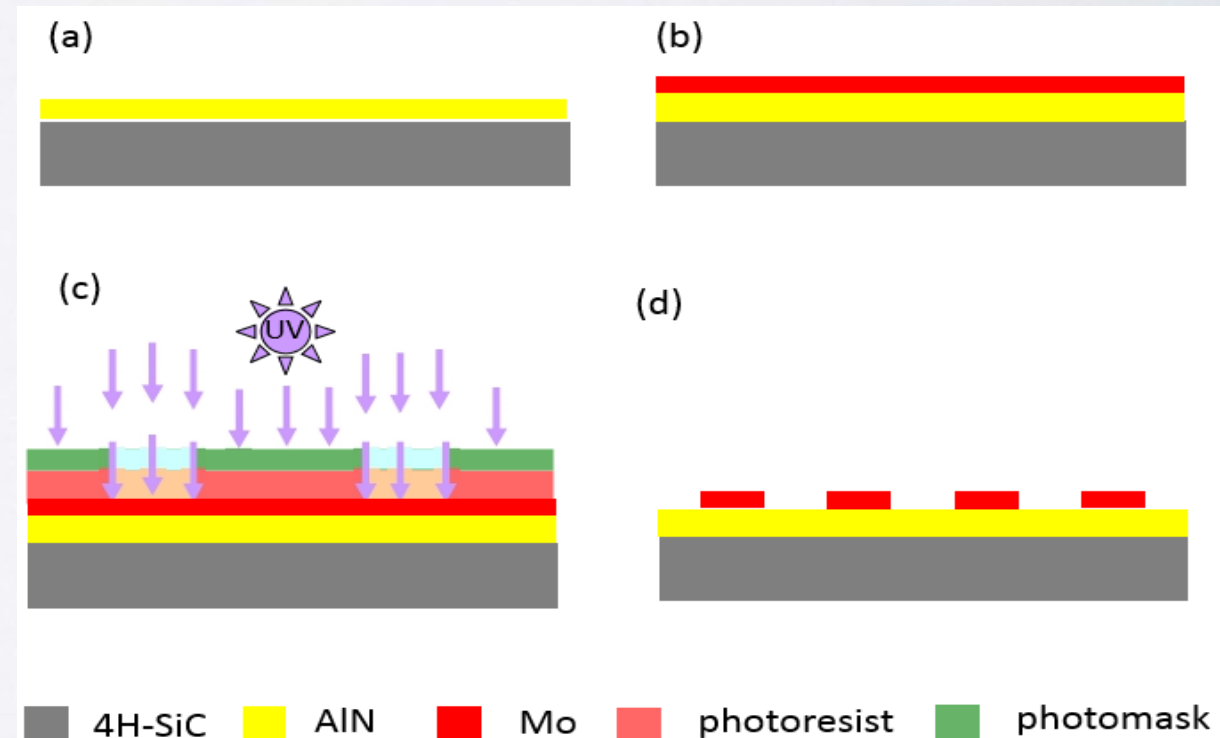
FEM simulation

Finite element simulation software COMSOL Multiphysics is used to simulate the device performance



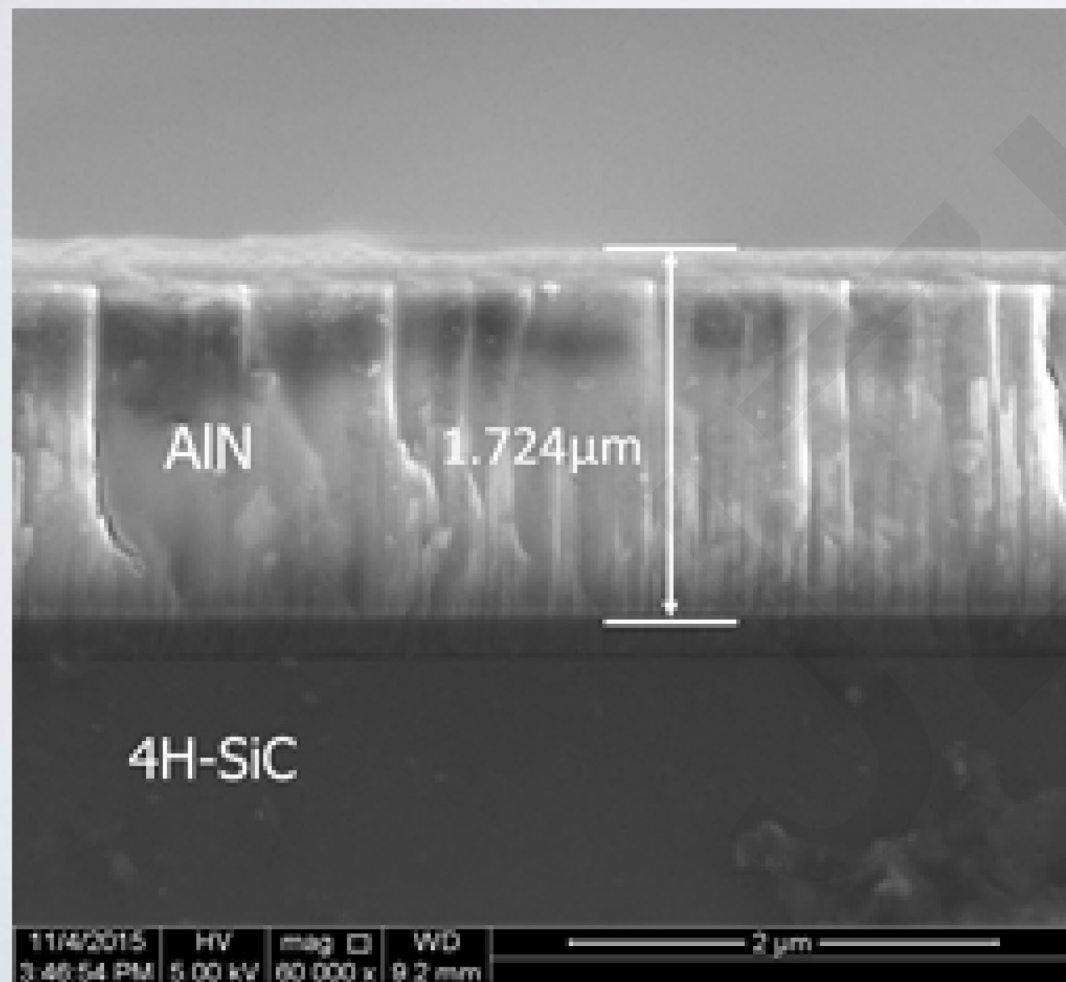
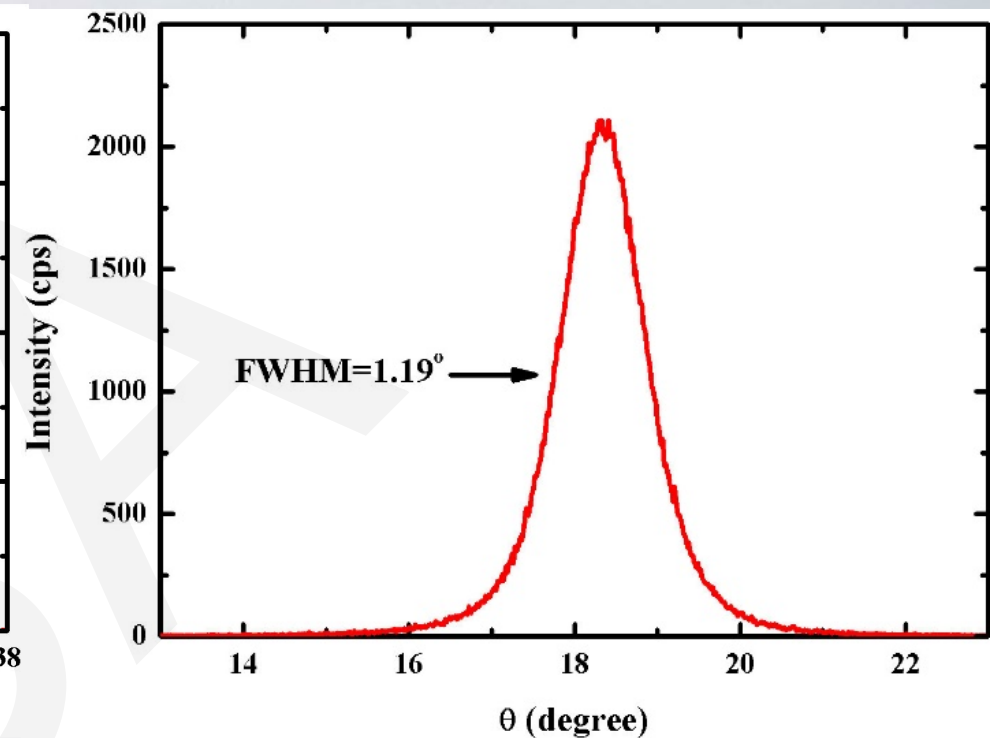
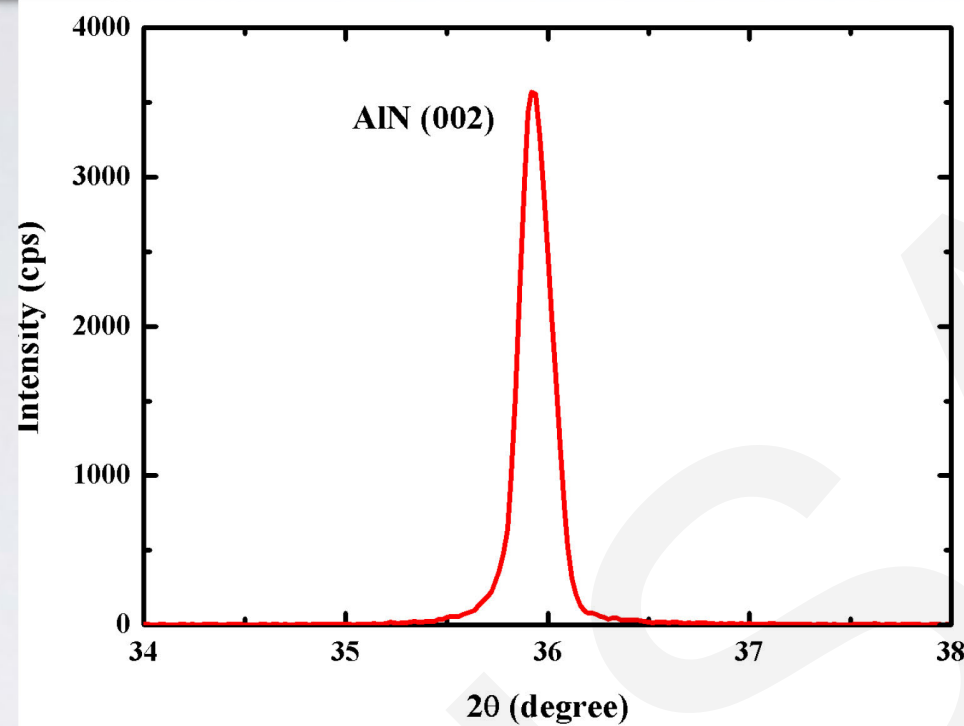
MEMS fabrication

- (a) AlN is deposited as piezoelectric layer on 4H-SiC.
- (b) Mo is deposited on AlN.
- (c) Mo is patterned through photoetching.
- (d) IDT and reflecting grating electrode were fabricated by wet etching.



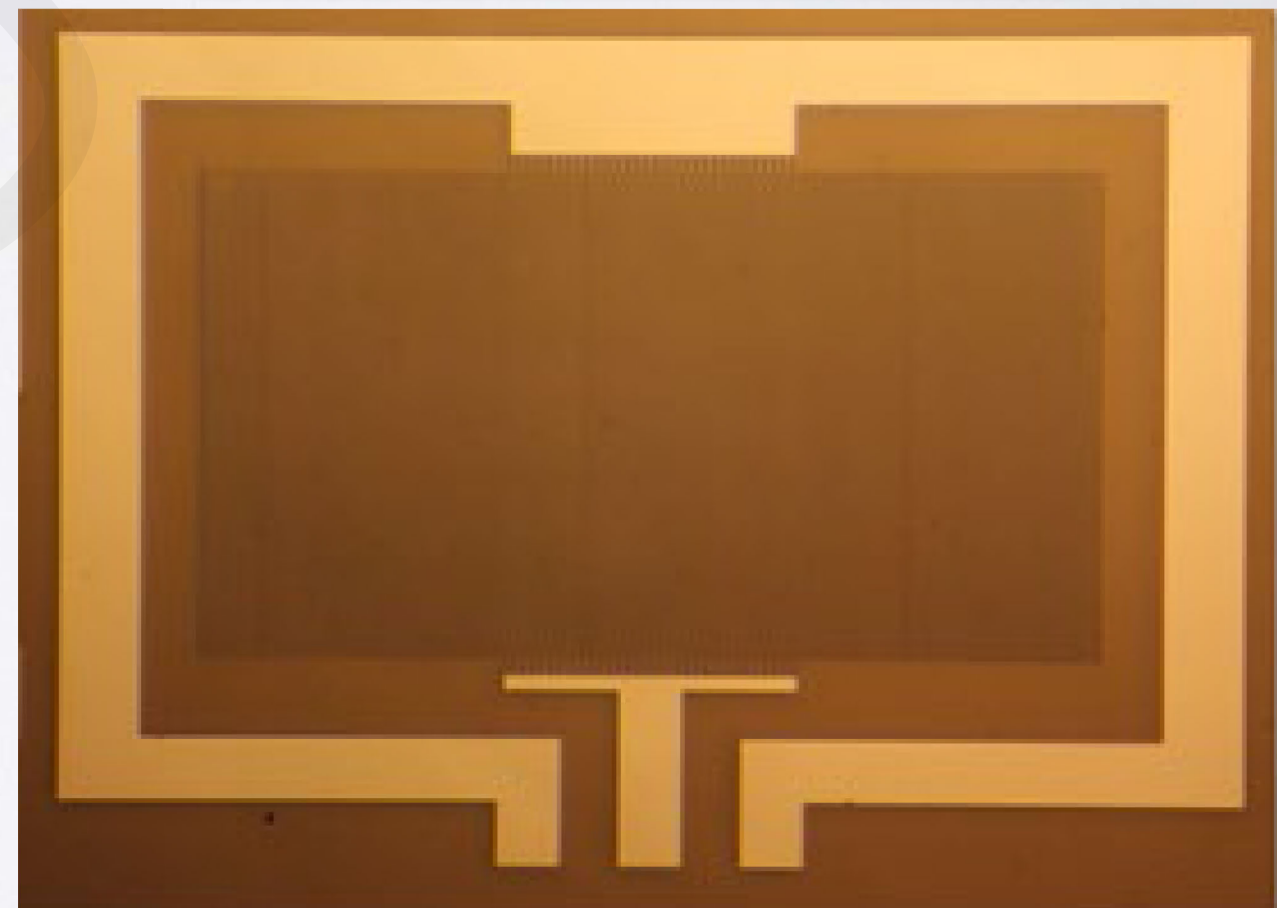
c-axis-oriented AlN thin films

- AlN thin film exhibits columnar grains perpendicular to the surface of the 4H-SiC layer
- High quality c-axis-oriented AlN thin film was grown on the 4H-SiC layer



XRD (35.92°)

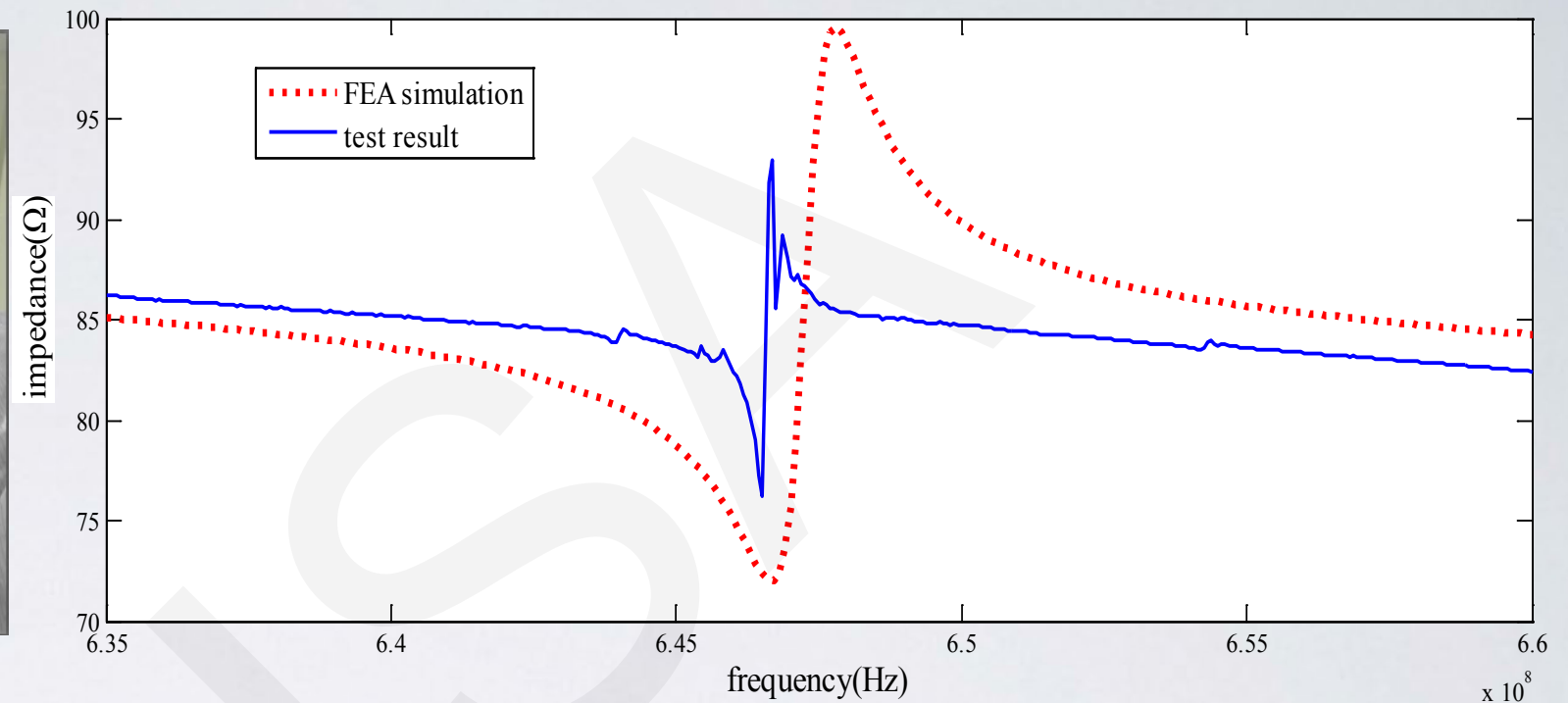
Fabrication result



Cross-sectional SEM micrographs of the 4H-SiC and AlN films

Optical image of the fabricated resonator

resonance frequency test



frequency-impedance chart of the FEA simulation and test result.

conclusions

- For the first time, a SAW resonator (size: $1107\mu\text{m} \times 721\mu\text{m}$) based on the AlN/4H-SiC multi-layer structure is designed and fabricated in this work.
- Highly c-axis-oriented AlN thin films were successfully deposited on the 4H-SiC substrate by using RF reactive magnetron sputtering and the lowest FWHM value is only 1.19° .
- a MEMS-compatible fabrication process has been employed to fabricate the SAW resonator.
- In comparison with the simulation curve, the test results of the network analyzer are consistent with it.